

60V N-Channel Trench MOSFET

General Description

• Trench Power SGT technology

- Very low on-resistance R_{DS(ON)}
- Low Gate Charge
- Excellent Gate Charge x R_{DS(ON)} Product

Applications

• High Frequency Switching and Synchronous Rectification

Product Summary

 V_{DS} 60V I_{D} (at V_{GS} =10V) 45A

 $R_{DS(ON)}$ (at $V_{GS} = 10V$) < $15m\Omega$

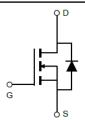
 $R_{DS(ON)}$ (at V_{GS} =4.5V) < 19m Ω

100% UIS Tested









Part Number	Package Type	Form	Marking	
TSD10N06AT	TO-252	Tape & Reel	D10N06AT	

Absolute Maximum Ratings (T_A =25°C unless otherwise noted)

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	60	V	
Gate-Source Voltage		V _{GS}	±20	V	
Continuous Drain Current B	T _C =25°C		45	Δ.	
Continuous Drain Current B	T _C =100°C		27	А	
Pulsed Drain Current A		I _{DM}	180	Α	
Avalanche Current A		I _{AS}	20	А	
Single Pulse Avalanche Energy L =0.3mH A		E _{AS}	20	mJ	
Power Dissipation ^C	T _C =25°C	Б	56.5	W	
	T _C =100°C	P _D	35.7	W	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 175	°C	

Thermal Characteristics

Parameter		Symbol	Maximum	Units	
Maximum Junction-to-Case	Steady-State	$R_{\Theta JC}$	2.1	°C/W	
Maximum Junction-to-Ambient	Steady-State	$R_{\Theta JA}$	50	°C/VV	



Electrica	al Characteristics(T _J =25ºC u	nless otherwise n	oted)				
Complete	Devementes	Conditions			Value		
Symbol	Parameter Conditions			Min	Тур	Max	Units
STATIC PA	RAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		60			V
	Z Cata Valtaria Drain Current	T _J =25°C			1		
I _{DSS}	Zero Gate Voltage Drain Current $V_{DS} = 60V, V_{GS}$	$V_{DS} = 60 \text{V}, V_{GS} = 0 \text{V}$	T _J =125°C			100	μA
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	•			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		1.1		2.5	V
	Otatia Basia Ossasa Os Basiatanas	V _{GS} =10V, I _D =20A			12	15	mΩ
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS} = 4.5V, I_D = 20A$			15	19	mΩ
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =20A			100		S
V _{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V	I _S =1A, V _{GS} =0V			1	V
I _S	Maximum Body-Diode Continuous Current B					30	Α
DYNAMIC I	PARAMETERS					•	
C _{iss}	Input Capacitance				1134		
C _{oss}	Output Capacitance	$V_{GS} = 0V$, $V_{DS} = 30V$, $f = 1MH_Z$			123		pF
C _{rss}	Reverse Transfer Capacitance		1		12		
SWITCHING	G PARAMETERS	•					
Q _g (10V)	Total Cata Charge				21		
Q _g (4.5V)	Total Gate Charge	10/// 20//	$V_{GS} = 10V, V_{DS} = 30V, I_{D} = 20A$		11		nC
Q_{gs}	Gate Source Charge	$V_{GS} = 10V, V_{DS} = 30V, I$			3.1		
Q_{gd}	Gate Drain Charge				5.1		
t _{D(on)}	Turn-On Delay Time				7		
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DS} = 30V, I_{I}$	$V_{GS} = 10V, V_{DS} = 30V, I_{D} = 20A,$		3		ns
$T_{D(off)}$	Turn-Off Delay Time	$R_G = 3\Omega$			20		
t _f	Turn-Off Fall Time		1		3		
t _{rr}	Body Diode Reverse Recovery Time	1 004 474 50044	_		17		ns
Q _{rr}	Body Diode Reverse Recovery Charge	-I _F =20A, di/dt =500A/μs			60		nC

- A. Single pulse width limited by maximum junction temperature.
- B. The maximum current rating is package limited.
- C. The power dissipation P_D is based on $T_{J(MAX)}$ =175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.



Typical Characteristics $T_J = 25^{\circ}\text{C}$, unless otherwise noted

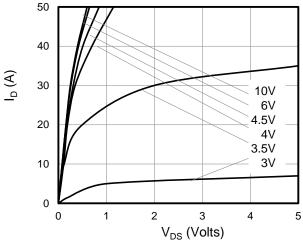


Figure 1: On-Region Characteristics

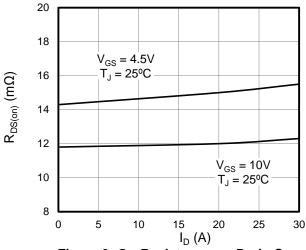


Figure 3: On-Resistance vs. Drain Current

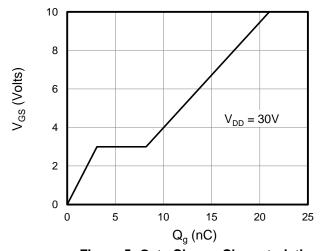


Figure 5: Gate Charge Characteristics

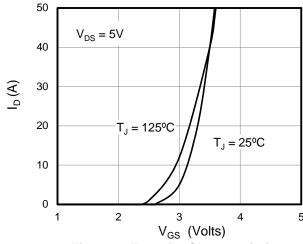


Figure 2: Transfer Characteristics

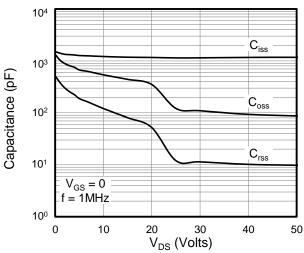


Figure 4: Capacitance Characteristics

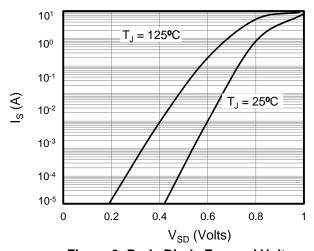
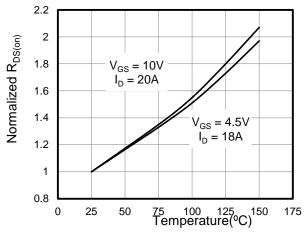
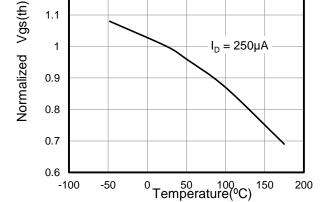


Figure 6: Body Diode Forward Voltage



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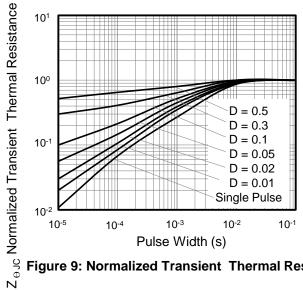




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Figure 7: On-Resistance vs. Junction Temperature

Figure 8: Vgs(th) vs. Junction Temperature



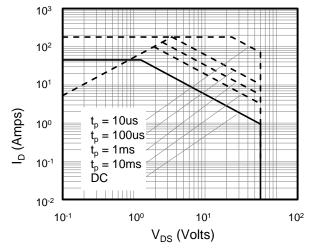


Figure 9: Normalized Transient Thermal Resistance

Figure 10: Safe Operating Area



Figure A: Gate Charge Test Circuit and Waveform

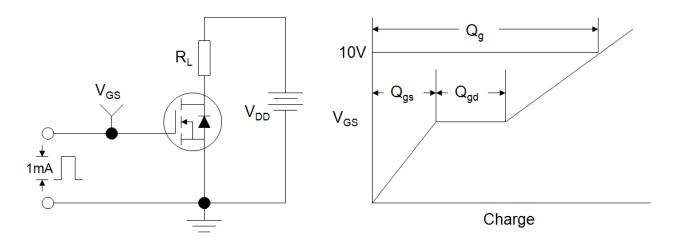


Figure B: Resistive Switching Test Circuit and Waveform

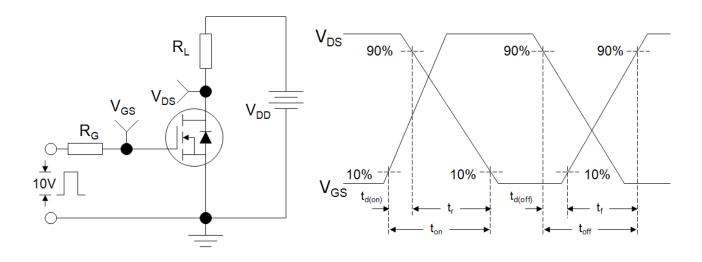
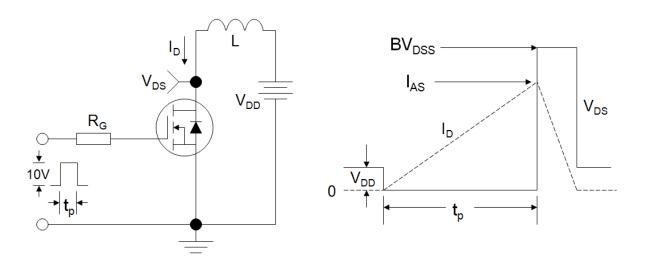
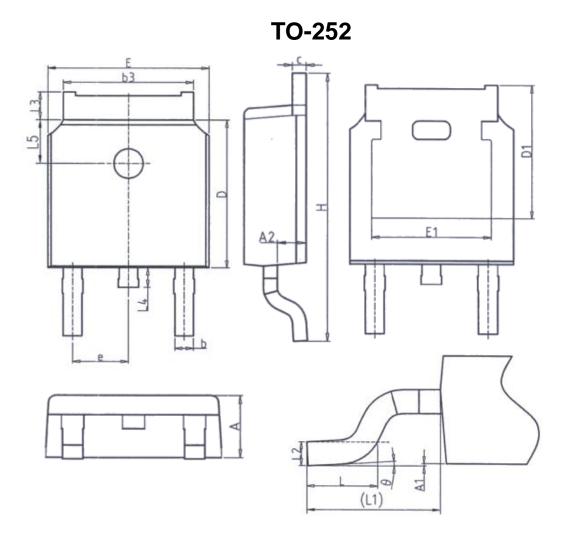


Figure C: Unclamped Inductive Switching Test Circuit and Waveform







Unit: mm				
Symbol	Min.	Max.		
Α	2. 20	2. 40		
A1	0.00	0. 20		
A2	0. 97	1. 17		
b	0. 68	0. 90		
b3	5. 20	5. 50		
С	0. 43	0. 63		
D	5. 98	6. 22		
D1	5. 30REF			
E	6. 40	6. 80		
E1	4. 63	_		

Unit: mm				
Symbol	Min. Max.			
е	2. 286BSC			
Н	9. 40	10.50		
L	1. 38	1. 75		
L1	2. 90REF			
L2	0. 51BSC			
L3	0.88	1. 28		
L4	- 1.00			
L5	1. 65	1. 95		
θ	0°	8°		



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